



## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application No.:

10/700,412

Filed:

November 4, 2003

Group Art Unit:

Not Known

Applicant(s):

Robert McClure et al.

Title:

POSITIONAL BLASTING SYSTEM

Attorney Docket No:

**DBS-02** 

Cincinnati, Ohio 45202

Date: March 30, 2004

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

# INFORMATION DISCLOSURE STATEMENT PURSUANT TO 37 C.F.R. §§ 1.56, 1.97, AND 1.98

Sir:

In accordance with 37 C.F.R. §§1.56, 1.97, and 1.98, in connection with the above-identified patent application, the Applicants call to the attention of the United States Patent and Trademark Office the references listed on the attached Form PTO-1449. A copy of each of the cited non-U.S. patent references is enclosed.

The Applicants request that the Examiner review the references and make an independent determination of their relevance.

Respectfully submitted,

WOOD, HERRON & EVANS, L.L.P.

By:

Douglas A. Scholer Reg. No. 52,197

WOOD, HERRON & EVANS, L.L.P. 2700 Carew Tower 441 Vine Street Cincinnati, Ohio 45202 (513) 241-2324 (voice) (513) 241-6234 (facsimile)

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SUBSTITUTE FORM PTO-1449

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

ATTY. DOCKET NO. DBS/02 SERIAL NO. 10/700,412

1 200 35 LB (37 CFR 1.985)

INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(Use several sheets if necessary)

APPLICANT Robert McClure et al.

FILING DATE November 4, 2003 GROUP Not Known

#### U.S. PATENT DOCUMENTS

EXAMINER INITIAL			PA	TEN	1T N	IUM	BEF	₹	ISSUE DATE	PATENTEE	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	A.A	3	6	1	8	5	1	9	11/09/1971	Griffith			12/23/1968
	A.B	3	9	0	3	7	9	9	09/09/1975	Walker			09/20/1973
	A.C	4	3	2	4	1	8	2	04/13/1982	Kirby et al.			01/22/1979
	A.D	4	6	1	5	2	6	8	10/07/1986	Nakano et al.			11/14/1984
_	A.E	4	6	7	4	0	4	7	06/16/1987	Tyler et al.			01/31/1984
	A.F	4	7	5	7	7	6	4	07/19/1988	Thureson et al.			12/20/1985
	A.G	4	7	7	7	8	8	0	10/18/1988	Beattie et al.	•		04/06/1987
	A.H	4	8	8	4	5	0	6	12/05/1989	Guerreri			11/06/1986
	A.I	4	9	7	6	1	9	9	12/11/1990	Beukes et al.			08/28/1989
	A.J	4	9	8	6	1	8	3	01/22/1991	Jacob et al.		V.	10/24/1989
	A.K	5	0	1	4	6	2	2	05/14/1991	Jullian		X	02/22/1990

#### FOREIGN PATENTS OR PUBLISHED FOREIGN PATENT APPLICATIONS

	DOCUMENT NUMBER	PUBLICATION DATE	COUNTRY OR PATENT OFFICE	CLASS	SUBCLASS	TRANSLATION (YES/NO)
A.L	WO 97 21067	06/12/1997	PCT			No
A.M	WO 96 16311	05/30/1996	РСТ			No
A.N	FR 2 688 583	09/17/1993	FR		,	Abstract Only
A.O						
A.P						
A.Q						

### OTHER DOCUMENTS (Including Author, Title, Date, Place of Publication)

A.R	Daveytronic , <u>BAI2001:Daveytronic Workshop</u> , "10th High Tech Seminar", Nashville, TN, July 22-26, 2001
A.S	
A.T	

**EXAMINER** 

DATE CONSIDERED

EXAMINER: Initial if citation considered, whether or not in conformance. Draw line through citation only if not in conformance <u>and</u> not considered. Include a copy of this form with next communication to applicant.

Sheet 2 (B) of 3

SUBSTITUTE FORM PTO-1449 U.S. DEPARTMENT (MODIFIED) PATENT AND TRAD										ENT OF COMMERCE TRADEMARK OFFICE					SERIAL NO. 0/700,412	
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EXAMINER INITIAL			PA	TEI	NT N	IUM	BEF	₹	ISSUE DATE	PATENTEE	CLASS		SUBC	LASS	FILING DATE IF APPROPRIATE	
	B.A	5	0	9	9 0 3 2			1	02/25/1992	Abouav					11/09/1988	
	B.B	5	1	1	7	7	5	6	06/02/1992	Goffin, II					09/20/1990	
	B.C	5	1	5	9	1	4	9	10/27/1992	Marsden					06/24/1991	
	B.D	5	2	1	4	2	3	6	05/25/1993	Murphy et al.					09/12/1989	
••	B.E	5	2	9	5	4	3	8	03/22/1994	Hill et al.					12/03/1992	
	B.F	5	3	8	6	7	8	0	02/07/1995	Klein					10/21/1992	
	B.G	5	3	8	8	5	2	1	02/14/1995	Coursen					10/18/1993	
	В.Н				7	0	9	0	09/05/1995	Adams					09/16/1993	
	5	5	7	1	0	1	8	11/05/1996	FitzGerald					11/23/1994		
	B.J	5	5	7	1	9	8	5	11/05/1996	Ritter et al.					04/25/1995	
	B.K 5					7	1	2	02/03/1998	Ewick et al.					10/25/1996	
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Sheet 3 (C) of 3

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EXAMINER INITIAL			PA	TE	1 TN	NUM	IBE	—— ₹	ISSUE DATE	PATENTEE	,	CLASS SUB		LASS	FILING DATE IF APPROPRIATE
	C.A	5	8	9	4	4 1 0			04/13/1999	Shann	_				11/14/1995
	С.В	6	0	7	9	3	3	3	06/27/2000	Manning	- · · · · · · · · · · · · · · · · · · ·				06/12/1998
	C.C	6	0	8	2	2	6	5	07/04/2000	Sakamoto et al.					07/24/1996
	C.D	6	1	7	3	6	5	1	01/16/2001	Pathe et al.					05/21/1997
	C.E	6	2	8	3	2	2	7	09/04/2001	Lerche et al.					10/27/1998
	C.F 6				2	1	4	7	07/23/2003	Shann					07/07/1999
					0	4	6	2	10/08/2002	Rosenstock					04/24/2000
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